LH534000B-S

CMOS 4M (512K × 8/256K × 16)
3V-Drive MROM

FEATURES

- 524,288 words × 8 bit organization
  (Byte mode)
  262,144 words × 16 bit organization
  (Word mode)
- Access times:
  500 ns (2.6 V ≤ V_{CC} < 4.5 V)
  200 ns (4.5 V ≤ V_{CC} ≤ 5.5 V)
- Wide range power supply: 2.6 to 5.5 V
- Static operation
- Three-state outputs
- Packages:
  40-pin, 600-mil DIP
  40-pin, 525-mil SOP
  48-pin, 12 × 18 mm^2 TSOP (Type I)

DESCRIPTION

The LH534000B-S is a 4M-bit mask-programmable ROM organized as 524,288 × 8 bits (Byte mode) or 262,144 × 16 bits (Word mode) that can be selected by $\overline{BYTE}$ input pin.

It is suited for use in compact battery back-up systems due to be operated on 3 V power supply.

PIN CONNECTIONS

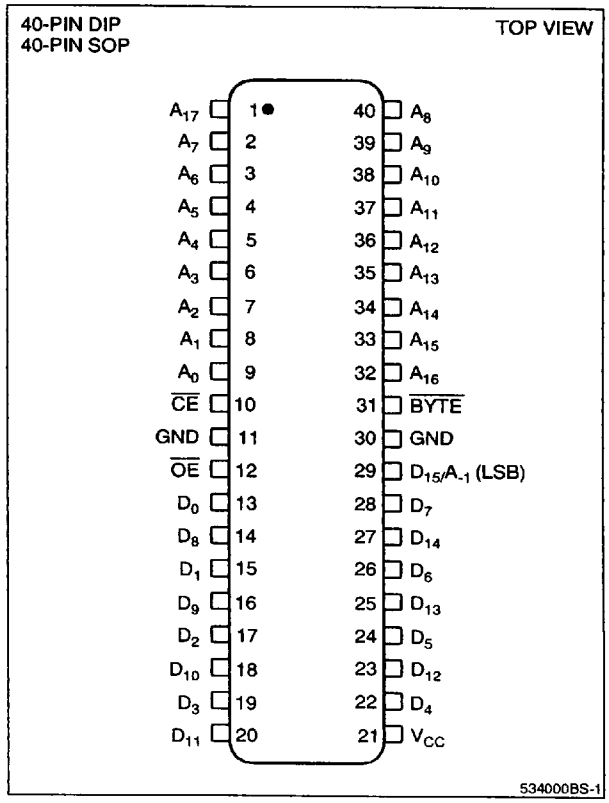


Figure 1. Pin Connections for DIP and SOP Packages

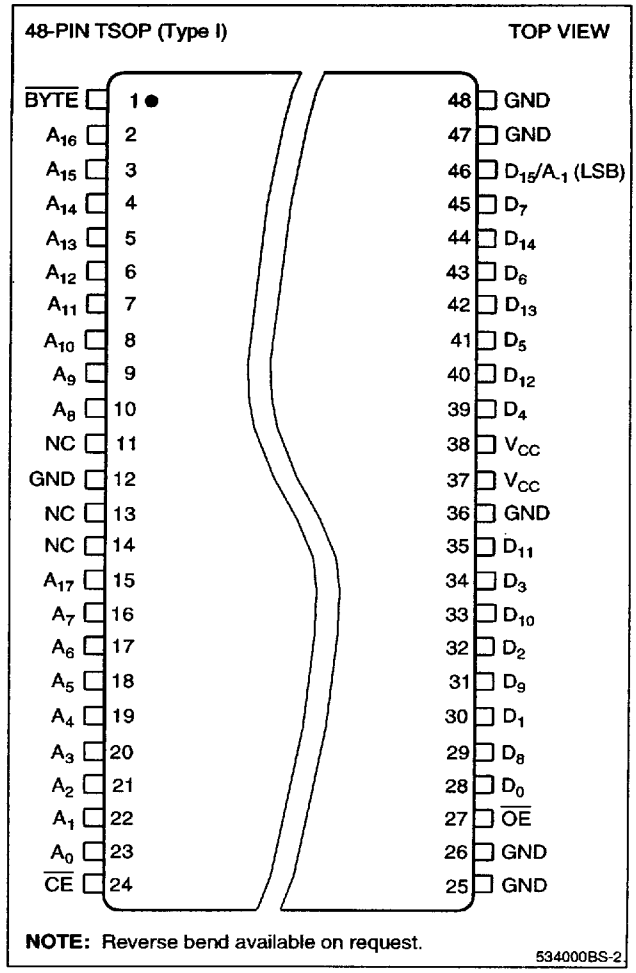


Figure 2. Pin Connections for TSOP Package

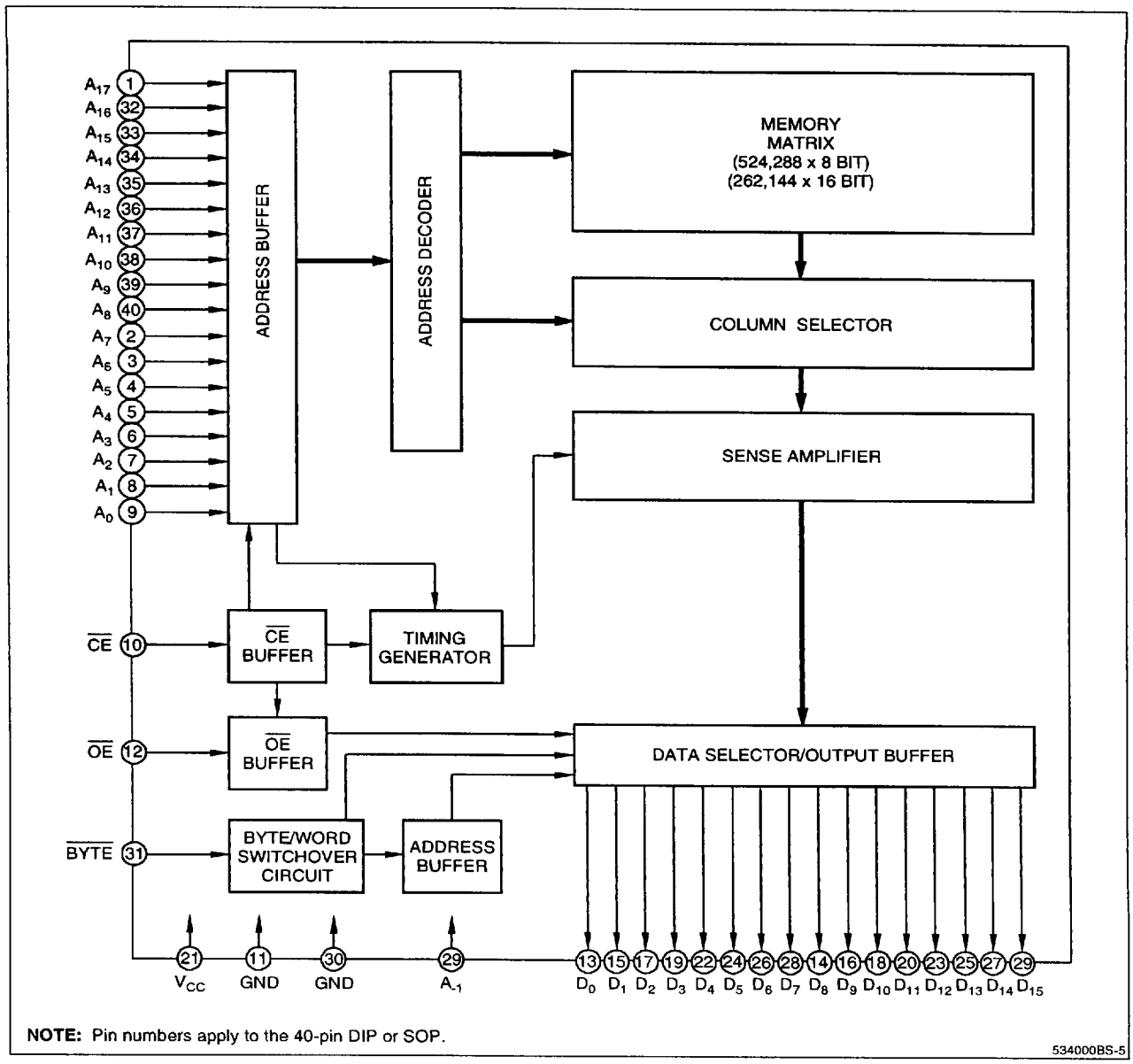


Figure 3. LH534000B-S Block Diagram

PIN DESCRIPTION

SIGNAL	PIN NAME	NOTE
$A_{-1} - A_{17}$	Address input	1
$D_0 - D_{15}$	Data output	1
$\overline{BYTE}$	Byte/word mode switch	1
$\overline{CE}$	Chip enable input	

SIGNAL	PIN NAME	NOTE
$\overline{OE}$	Output enable input	
V_{CC}	Power supply	
GND	Ground	

NOTE:

1. The D_{15}/A_{-1} pin becomes LSB address input (A_{-1}) when the bit configuration is set to byte mode, and data output (D_{15}) when in word mode. The $\overline{BYTE}$ input pin selects bit configuration.

TRUTH TABLE

$\overline{CE}$	$\overline{OE}$	$\overline{BYTE}$	DATA OUTPUT		ADDRESS INPUT		SUPPLY CURRENT
			$D_0 - D_7$	$D_8 - D_{15}$	LSB	MSB	
H	X	X	High-Z	High-Z	–	–	Standby
L	H	X	High-Z	High-Z	–	–	Operating
L	L	H	$D_0 - D_7$	$D_8 - D_{15}$	A_0	A_{17}	Operating
L	L	L	$D_0 - D_7$	High-Z	A_{-1}	A_{17}	Operating

NOTE:
X = H or L, High-Z = High-impedance

ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	RATING	UNIT
Supply voltage	V_{CC}	−0.3 to +7.0	V
Input voltage	V_{IN}	−0.3 to V_{CC} + 0.3	V
Output voltage	V_{OUT}	−0.3 to V_{CC} + 0.3	V
Operating temperature	Topr	0 to +70	°C
Storage temperature	Tstg	−55 to +150	°C

RECOMMENDED OPERATING CONDITIONS (T_A = 0 to +70°C)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Supply voltage	V_{CC}	2.6		5.5	V

DC CHARACTERISTICS (V_{CC} = 2.6 to 5.5 V, T_A = 0 to +70°C)

PARAMETER	SYMBOL	CONDITIONS	MIN.	MAX.	UNIT	NOTE
Input 'High' voltage	V_{IH}		0.8 V_{CC}	V_{CC} + 0.3	V	
Input 'Low' voltage	V_{IL}		−0.3	0.4	V	
Output 'High' voltage	V_{OH}	I_{OH} = −100 µA	0.8 V_{CC}		V	
Output 'Low' voltage	V_{OL}	I_{OL} = 400 µA		0.4	V	
Input leakage current	$\lvert I_{LI} \rvert$	V_{IN} = 0 V to V_{CC}		10	µA	
Output leakage current	$\lvert I_{LO} \rvert$	V_{OUT} = 0 V to V_{CC}		10	µA	1
Operating current	I_{CC1}	t_{RC} = 200 ns		50	mA	2
	I_{CC2}	t_{RC} = 1 µs		45	mA	2
	I_{CC3}	t_{RC} = 200 ns		45	mA	3
	I_{CC4}	t_{RC} = 1 µs		40	mA	3
Standby current	I_{SB1}	$\overline{CE}$ = V_{IH}		3	mA	
	I_{SB2}	$\overline{CE}$ = V_{CC} − 0.2 V		100	µA	
Input capacitance	C_{IN}	f = 1 MHz, T_A = 25°C		10	pF	
Output capacitance	C_{OUT}			10	pF	

NOTES:
1. $\overline{CE}/\overline{OE}$ = V_{IH}
2. V_{IN} = V_{IH} or V_{IL}, $\overline{CE}$ = V_{IL}, outputs open
3. V_{IN} = (V_{CC} − 0.2 V) or 0.2 V, $\overline{CE}$ = 0.2 V, outputs open

AC CHARACTERISTICS (T_A = 0 to +70°C)

PARAMETER	SYMBOL	2.6 ≤ V_{CC} < 4.5		4.5 ≤ V_{CC} ≤ 5.5		UNIT	NOTE
		MIN.	MAX.	MIN.	MAX.		
Read cycle time	t_{RC}	500		200		ns	
Address access time	t_{AA}		500		200	ns	
Chip enable access time	t_{ACE}		500		200	ns	
Output enable delay time	t_{OE}		150		80	ns	
Output hold time	t_{OH}	10		10		ns	
CE to output in High-Z	t_{CHZ}		150		80	ns	1
OE to output in High-Z	t_{OHZ}		150		80	ns	

NOTE:
1. This is the time required for the outputs to become high-impedance.

AC TEST CONDITIONS

PARAMETER	RATING
Input voltage amplitude	0.4 to 0.8 V_{CC}
Input rise/fall time	10 ns
Input/output reference level	1.5 V
Output load condition	1 TTL + 100 pF

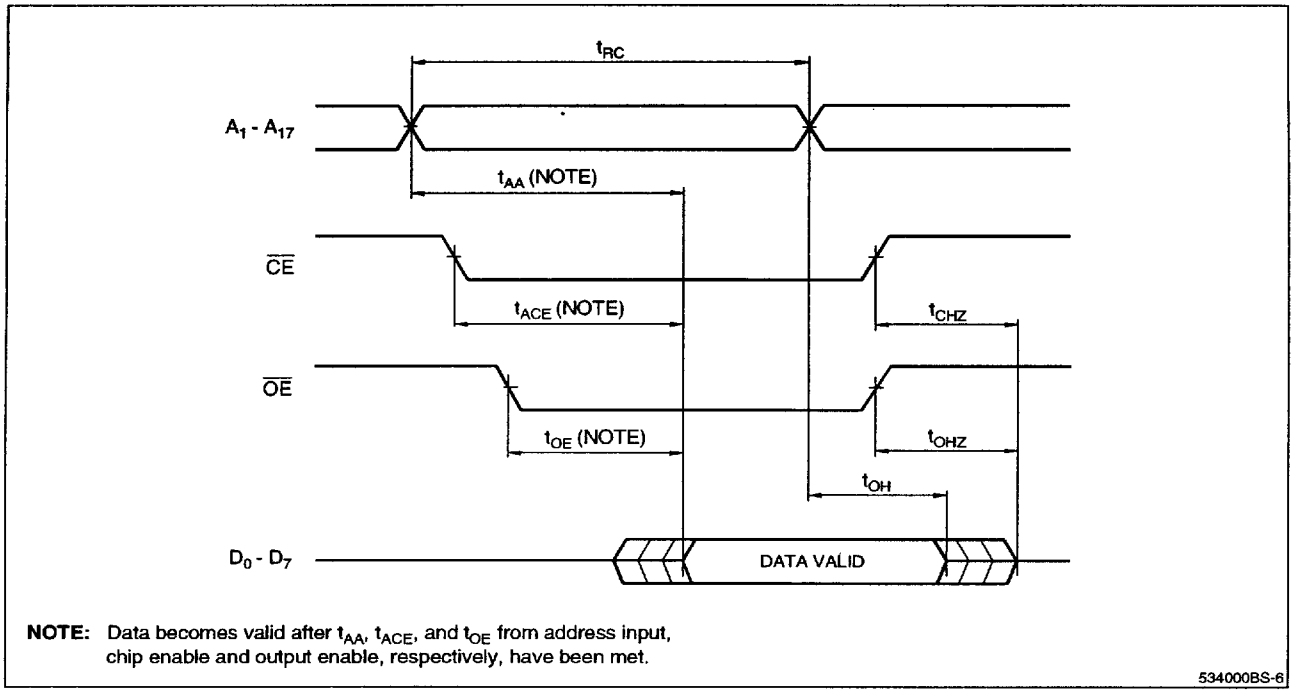


Figure 4. Byte Mode ($\overline{BYTE}$ = V_{IL})

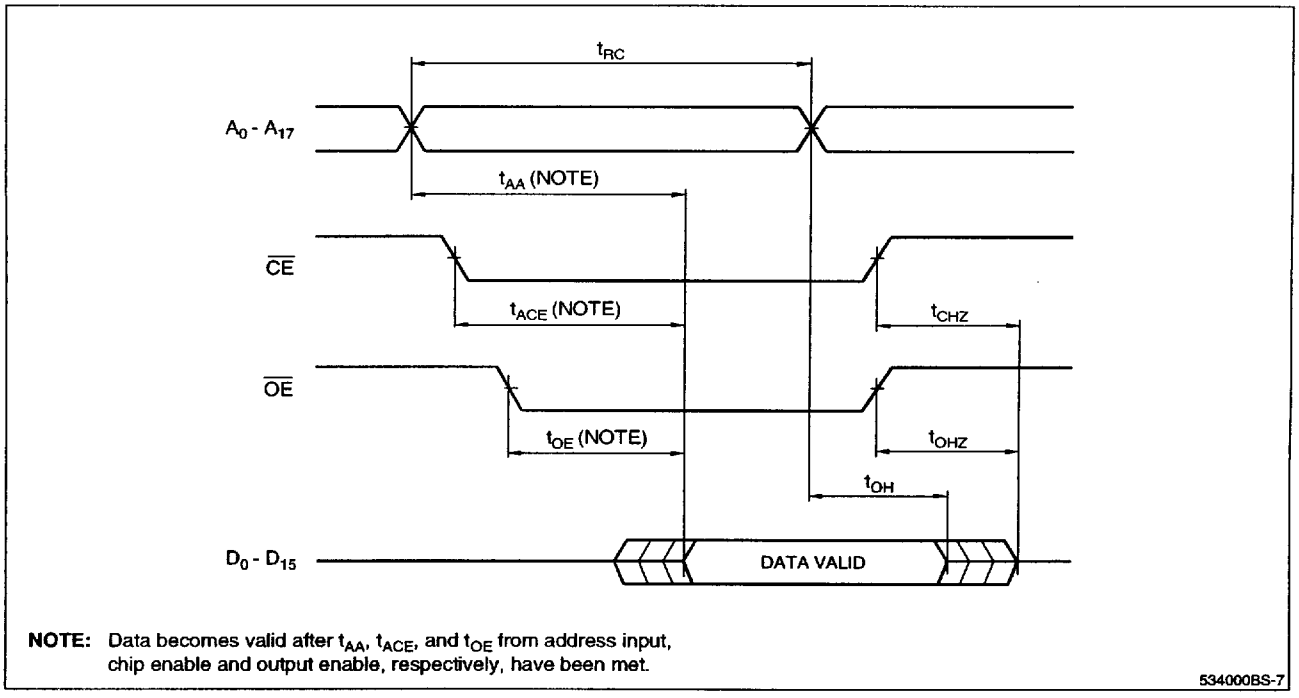
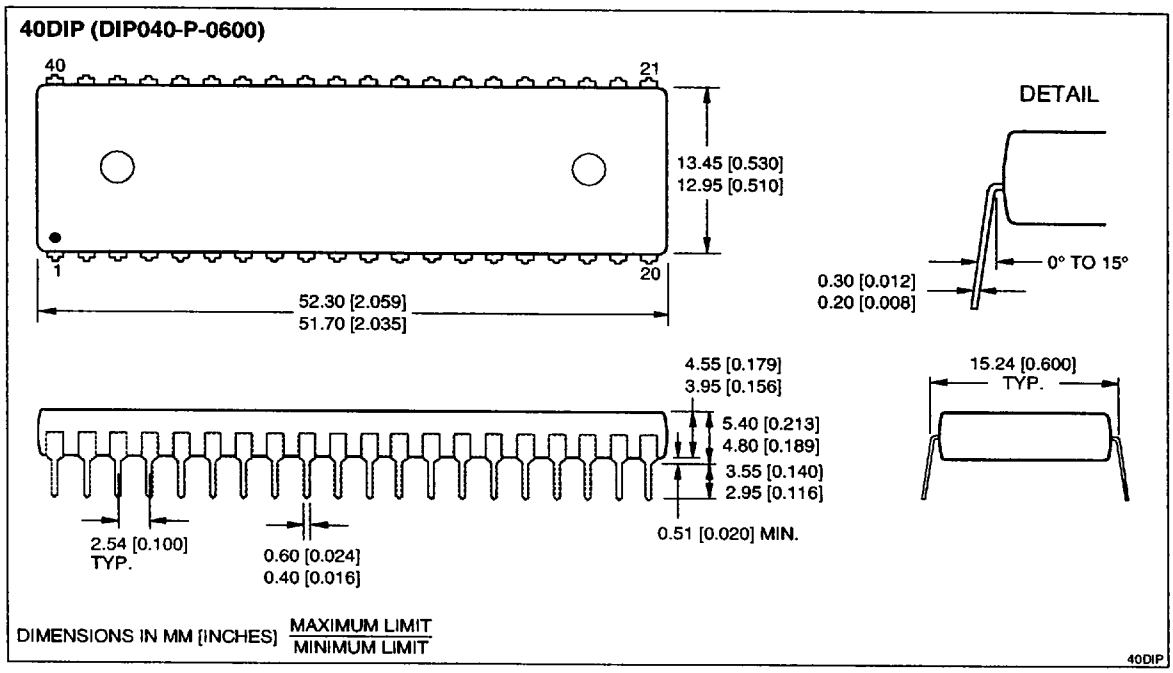
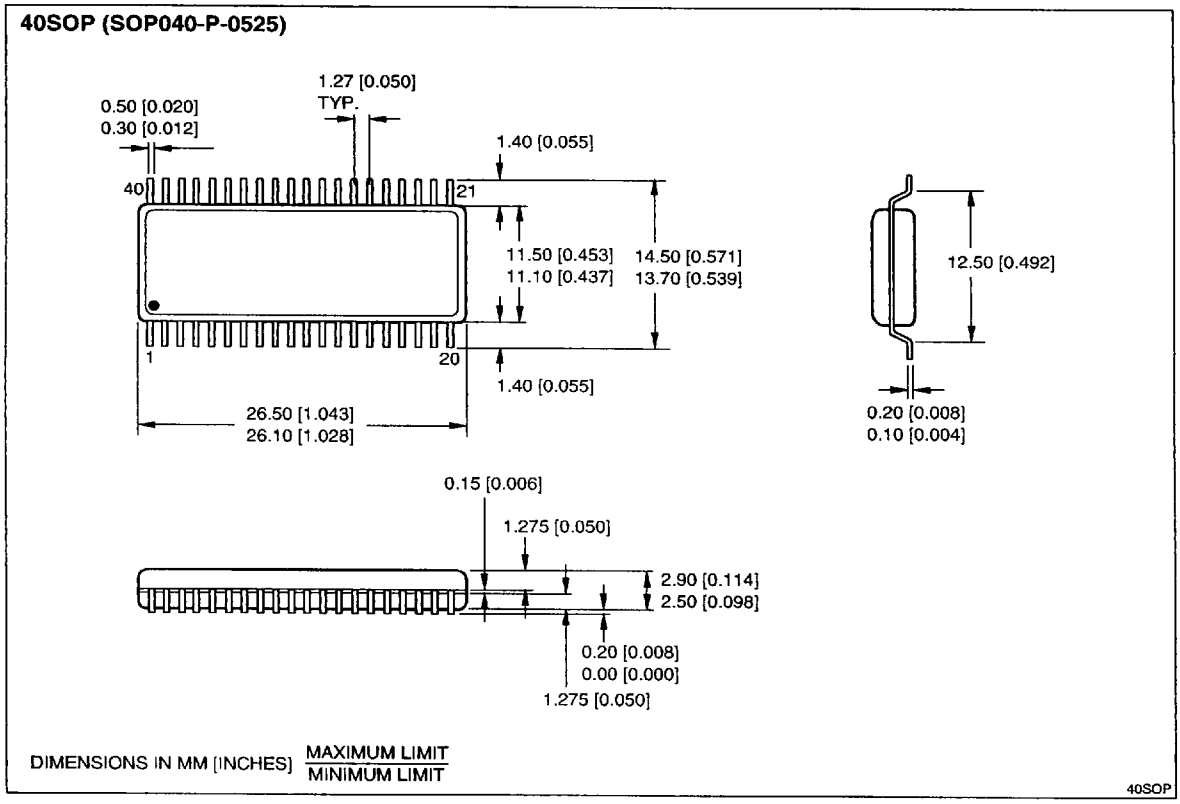


Figure 5. Word Mode ($\overline{BYTE}$ = V_{IH})

PACKAGE DIAGRAMS

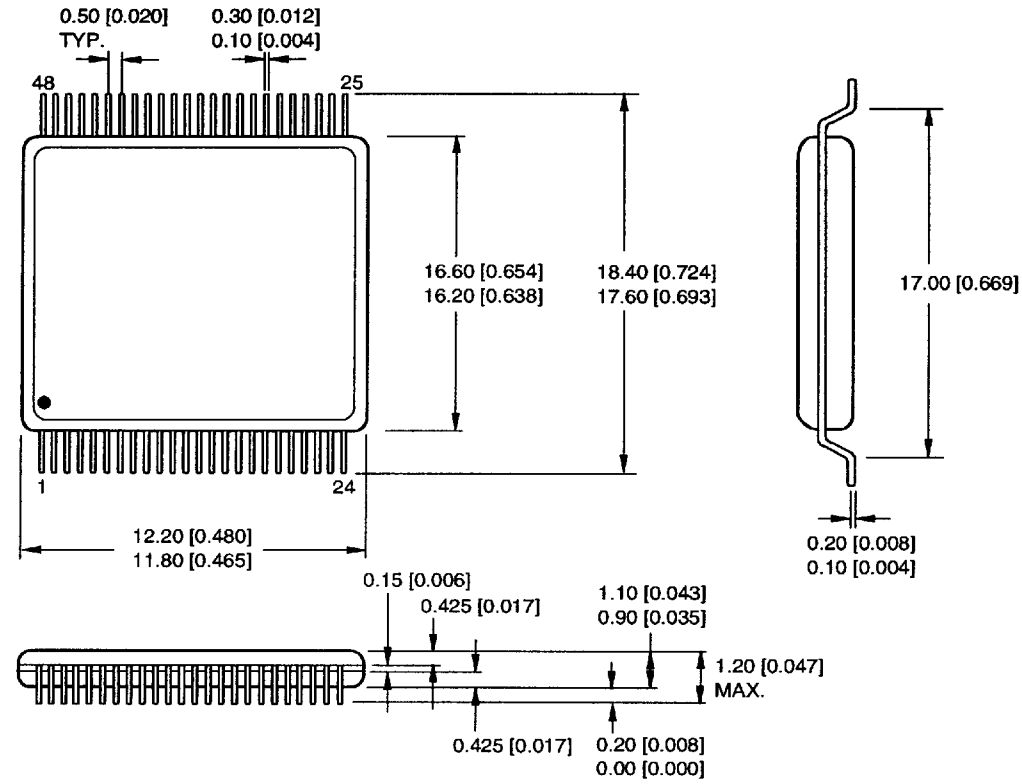


40-pin, 600-mil DIP



40-pin, 525-mil SOP

48TSOP (TSOP048-P-1218)



48-pin, 12 × 18 mm^2 TSOP (Type I)

ORDERING INFORMATION

LH534000B	X	- S
Device Type	Package	Low-Voltage Operation

- D 40-pin, 600-mil DIP (DIP040-P-0600)
- N 40-pin, 525-mil SOP (SOP040-P-0525)
- T 48-pin, 12 x 18 mm^2 TSOP (Type I) (TSOP048-P-1218)
- TR 48-pin, 12 x 18 mm^2 TSOP (Type I) Reverse bend (TSOP048-P-1218)

CMOS 4M (512K x 8 or 256K x 16) Mask-Programmable ROM

Example: LH534000BD-S (CMOS 4M (512K x 8 or 256K x 16) Mask-Programmable ROM, Low-Voltage Operation, 40-pin, 600-mil DIP)

534000BS-8

8180798 0022452 T23

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